

MULTI-INNO TECHNOLOGY CO., LTD.

http:// www.multi-inno.com

TOUCH PANEL SPECIFICATION

Model : MI0500CBP-C

Customer :

Approved	
Commont	

Revision	1.0
Engineering	
Date	2012-12-08
Our Reference	



REVISION RECORD

REV NO.	REV DATE	CONTENTS	REMARKS
1.0	2012-12-08	First Release	



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■ GENERAL SPECIFICATIONS

The projected capacitive touch technology applied to this product is an ITO-based touch technology. It consists of one glass substrate layers with ITO coating patterned into a grid of rows/columns and cover lens that are laminated together. During a touch, the capacitance of the finger changes the capacitive coupling between the grid elements on the location of the touch. This location is calculated from the change in electrical characteristics of the sensor grid. Mathematical processing, programmed in the Touch Controller chip, is used to recognize this distortion. Capacitive sensors can be touched with a bare finger or a conductive device being held by a bare hand. They are not affected by outside elements and have high clarity.

The purpose of this specification is to define the general provisions and quality requirements that apply to the supply of capacitive touch sensor or capacitive touch panel (CTP) module manufactured by Multi-Inno. This document, together with the Module Drawing, is the highest-level specification for this product. It describes the product and contains specifications.

Features	Details	Unit	Note
Operation Technology	Projected capacitive		1
Product structure	Glass Lens-Glass Sensor		2
Input Method	Bare finger		
Number of simultaneous touches	2 points multi-touch		
Minimum Touch Area	Φ7	mm	
Surface Treatment	-	Н	
Finger Pitch	≥13	mm	
Connection Type	FPC,10pin, Pitch0.5mm		—
Customer Application	Industry		
CTP and LCD Assembly	Optical bonding/DST		
FG Weight	TBD	g	

Note 1: Mutual mode.

Note 2: RoHS compatible.



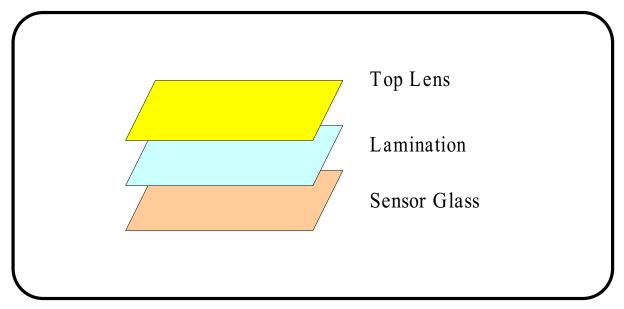
PRODUCTION DESCRIPTION

1 General description

Item	Contents	Unit	Note
Product size	5.0	inch	
TP outline	123.26 (W) x 80.06 (H) x 1.35(T)	mm	
TP active area	110.40(W) x 67.20(H)	mm	
Resolution	640*480		
Operation temperature	-20~70	°C	
Storage temperature	-30~80	°C	
Control IC	NT11003QG-48/A		
Interface	I2C		1

Note 1: It can be compatible with Andriod .

2 Structure description



Structure of touch panel



3 DC Characteristics

(T_A= 25℃,VDD=3.3V)

Item	Min	Тур	Max	Unit	Note
power supply voltage	2.7		3.6	V	DC(noise should be under 100mV)
IOVDD	1.65		3.6	V	
Power Consumption			10	mW	One finger on sensor
Sleep mode			20	uA	1
Respond time			12	ms	

Note1: All current measurement is average current.

4 Interface Timing Chart

4.1 IIC Timing

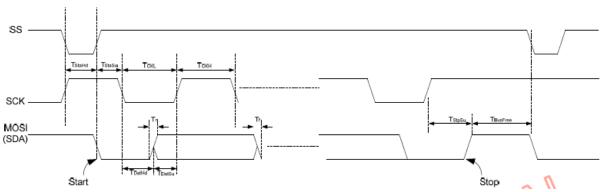


Fig4: IIC Timing

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Working Frequency	Fclk	0		400	KHz	
I2C Clock Low	TCKL	1250			ns	VDD =3.3V, TA=25.
I2C Clock High	ТСКН	1250			ns	VDD =3.3V, TA=25.
I2C Data Rising Time	Tr			300	ns	VDD =3.3V, TA=25.
I2C Data Falling Time	Tf			300	ns	VDD =3.3V, TA=25.

The IIC Timing Table as follows.



I2C Data Hold Time	TDatHd	0		ns	VDD = 3.3V, TA=25.
I2C Data Setup Time	TDatSu	100		ns	VDD = 3.3V, TA=25.
I2C Start Condition Hold Time	TStaHd	600		ns	VDD = 3.3V, TA=25 . VDD =3.3V, TA=25℃.
I2C Start Condition Setup Time	TStaSu	600		ns	VDD = 3.3V, TA=25 .
I2C Stop Condition Setup Time	TStpSu	600		ns	VDD = 3.3V, TA=25 .
I2C Bus Free Time	TBusFree	1300		ns	VDD = 3.3V, TA=25.

4.2

Register Definition

We reserve 42 bytes I2C buffer for recording gesture information and 4 bytes system control register for system designer to control touch panel appropriate for your requirement.

Address		I2C Buffer Definition						
00Н	GID 1	GID 2	P1_D1	P1_D2	P1_D3	P1_D4	P2_D1	P2_D2
08H	P2_ D3	P2_D4	P3_D1	P3_D2	P3_D3	P3_D4	P4_D1	P4_D2
10H	P4_ D3	P4_D4	P5_D1	P5_D2	P5_D3	P5_D4	P6_D1	P6_D2
18H	Р6_ D3	P6_D4	P7_D1	P7_D2	P7_D3	P7_D4	P8_D1	P8_D2
20H	P8_ D3	P8D4	P9_D1	P9_D2	P9_D3	P9_D4	P10_D1	P10_D2
28H	P10 _D3	P10_D4	F/W Ver.	Pwr_Ct 1_1	Pwr_Ct 1_2	Read_P nt	Reserv e	Reserv e



5 Mechanical Characteristics

No.	Item	Requirement	Verification method
1	Surface hardness	6Н	JIS-K5600
2	Drop ball test	No crack after test.	Use the 64g steel ($\not\subset$ 25) ball is dropped on the Glass surface from 70cm height at 1time(Glass side)
3	Surface pressure Test	No crack after test.	15 Kgf pressure in the center of the display using a rubber test head with a diameter of 15mm, 1 time,1 minute, non-operation
4	Terminal Pull Test	Function is OK	±90° direction, weight:500g, non-operation

6 Electrical Characteristics

condition (Ta=25°C,VDD=3.3V)

No.	ltem	Specification	NOTE
1	Linearity	±1mm	1.5mm at the border
2	Veracity	±1mm	1.5mm at the border
3	Sensivity	±1mm	15mm at the border
4	ESD	TBD	C=150pF、R=330Ω Air=±8KV 5times; contact::±4KV 5times (Environment: 15℃~35℃、 30%~60%,86Kpa~106Kpa)

7 Optical Characteristics $(Ta = 25 \degree C)$

No.	ltem	Min.	Тур.	Max.	Unit	Remark
1	Transmission	86	88		%	Note 1
2	Reflectivity				%	Note 1,Note 2
3	HAZE				%	

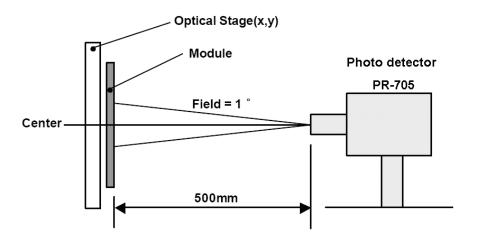
Note1: Measuring equipments: DMS-501, PR-705. @550nm

Measuring condition:

- After stabilizing and leaving the panel alone at a given temperature for 30 min, the measurement should be executed,

- Measuring surroundings: a stable, windless and dark room,
- Measuring temperature: Ta=25°C,
- 30 min after lighting the back-light.





Note2: conform to National standard GB2410-80 /ASTM D1003-61(1997)

CIRCUIT BLOCK DIAGRAM

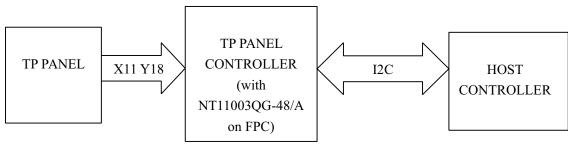


Fig2. System Block Diagram

■ PIN CONNECTIONS

Pin No.	Symbol	I/O	Description	Remark
1	GND	Р	Ground	
2	RESET	I/O	Active Low	
3	VDD	Р	Power	
4	INT	Р	Active Low	
5	SCL	I/O	CLOCK	
6	SDA	I/O	Data I/O	
7	TP_SYNC	I/O	GPIO from LCD	
8	NC	-	No connection	
9	NC	-	No connection	
10	NC	-	No connection	



■ RELIABILITY

No	Test Item	Test condition	Criterion
1	Lligh Temperature Storage	+80℃±2℃	
	High Temperature Storage	Power off	
2	Low Tomporatura Storage	-30°C±2°C	
2	Low Temperature Storage	Power off	
3	High Tomporature Operation	+70℃±2℃	
3	High Temperature Operation	Power on	
4	Low Tomporature Operation	-20℃±2℃	
4	Low Temperature Operation	Power on	
5	High Temperature & Humidity	+60℃±2℃	
5	Storage	90%RH±2%RH,	
6	Thermal Shock Test(storage)	-20°C (30min) \Leftrightarrow 70°C (30min) ,Change	
0		Time:5min	
7	Package Drop Test	Height:60cm,	
/	Fackage Drop Test	1corner,3edges,6surfaces	
		Half Sine Wave	
8	Package Vibration Test	50G 6ms, ±X,±Y,±Z	
		3times for each direction	

Note: Additional test Item proposed by customer shall be determined by mutual agreement between customer and Multi-Inno

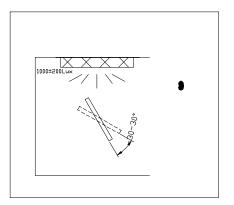
For consumer production uses, we recommended the temperature operation range of 0~60 d egree, beyond this temperature range can still be used, but the performance may be decrease, the difference with the production will be different.

■ SPECIFICATION OF QUALITY ASSURANCE

1 Inspection condition

- a. Inspected Temperature: $20 \sim 25$ °C, Inspected Distance: 30 ± 5 cm.
- b. Viewing Angle:

When inspecting, keep the eyesight perpendicular to the product surface:90 \pm 30 degree, as below.



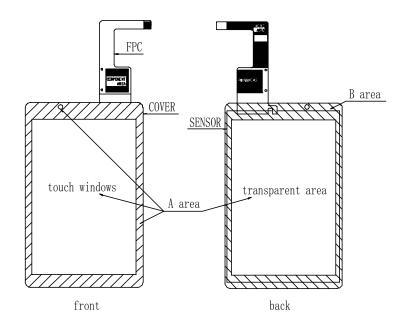
c. Inspected illumination: 1000 ± 200 Lux.

d. Inspected background: Under black background



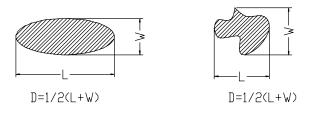
2 Definiton for the appearance area.

A area: The front area of the sample and the transparent area from the backside; as below; B area: The backside printing area. As below.

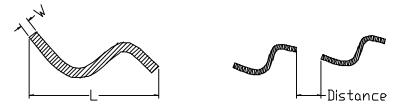


3 Definiton for the defects.

a. Circular Defects:



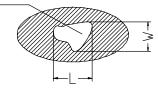
D: diameter W:width L: length (the same as below) b. Linear Defects:



c. Pin hole(Translucidus)

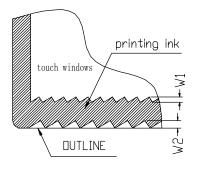


pin hole

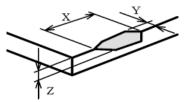


D=1/2(L+W)

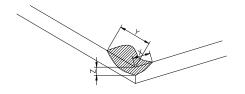
d. Zigzag for the printing ink



e. Edge Crack Chip



f. Corner Crack Chip



g. Bad Crack





4 Foreign object

No.	Inspection items	Judgment standard(Unit: mm)					
		Defect Size Judgment (A Area)		Judgment			
					(B Area)		
		D≤0.20	Neglecte	d(distance≥10) Neglected		
	Circular Defects(Dot、 Impurity、Dust、Bubble))	_		
		0.20≤D≤0.3	N≤5, (c	listance≥10)	_		
		D>0.3		tallowed			
1		Notes: 1、The c	ircular defe	cts which can	be removed is		
			ignored.				
		2、The circular defects of B area should not					
		affect to assembly					
		3, The circular defects of A area does not					
		include the protective film, TThe circular defects of B area					
		does not include the adhesive tapes.					
		W(width)/L(length)		Judgment			
		₩≤0.10, L≤3.0		Neglected(distance≥10)			
2	Linear Defects(Scratch Line\Foreign material)	0. 10<₩≤0.20, L≤3.0		N≤3, (distance≥10)			
		₩>0. 2, L>3. 0 Not allowed					
		Notes: The foreign meterial which can be removed is					
			igno	red.			
		Defect Size	Judgmen	t (A Area)	Judgment (B		
					Area)		
		D≤0.15	Neglected	(distance≥10	Neglected		
)			
		0.15≤D≤0.3	N≤3, (di	stance≥10)			
3	Dent	D>0.3		NG			
		Notes: 1. The foreign meterial which can be removed is					
		ignored.					
		2、The foreign meterial of B area should not					
		affect to assembly	,functionali	ty or final look	of the product.		



4	Dirt/Fingerprint/	A area: not allowed;
	Smokes/Snake/Rainbo	B area: neglected (Not affect to assembly,functionality or
	w effect	final look of the product.)
	w ellect	
5	Printing ink color	The printing ink color should be consistent with design
		drawing. (or client standard sample).
		1. The judgement area is the front non-translucent zone
		of the sample.
		2、 Accept the same series ink color printing shift.
6	Printing ink color	3、Color difference of IR hole,light sensor hole is not
	difference	inspected.
		4. If there is customer's inspection criteria or
		sample,determining by customer's inspection criteria or
		standard sample.
7	Transmittance-rate (IR	Meet design drawing.
8	hole\light sensor hole) Printing pin hole	Not allowed
		Font / Logo should be printed smooth, no jagged,
9	Font / Logo	shadow, penetration, wear and tear, displacement,
		disconnection and connection defects
10	Breakage on edge or	A area(front side): not allowed
10	corner	B area(back side): X≤0.2,Y≤0.2,Z≤1/5T; N≤2, (distance≥20), Neglected
11	Crack	Not allowed
		1、 the front (back) printing ink edge of the touch window
	Printing ink Edges	region :
12	burrs /	W1 \leq 0.2, OK; W1 $>$ 0.2, NG.
	Printing ink Zigzag	2、the front (back) printing ink edge of the sample: W2≤0.3, OK; W2>0.3, NG。
		(1).The touch windows + $0 \sim 2.0$ mm the criteria is same
	Foreign material of	to Circular Defects;
13	printing area	(2). The touch windows + 2.0 \sim 5.0mm : D≤0.3 ,
		Neglected(distance≥5.0) (3).The other areas:D≤0.5, Neglected(distance≥5.0)
	Circular Defects for	Sensor hole, LED hole: $D \le 0.1 \text{ mm}$, $N \le 1$, allowed ;
1 1	Circular Defects for LED hole/	D>0.1mm, not allowed;
14	IR hole/sensor hole	IR hole: D≤0.1mm, neglected;
		D>0.1mm, not allowed.
15	Bad cutting section for	1.Cutting section allow the wave-like phenomenon, but the cutting edge level of view must be a smooth line;
10	cover/sensor	2, cutting section does not allow any cracks appearance.



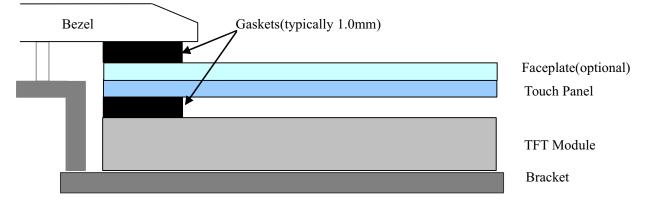
16	Surface Dirt	 the process dirt which can not wipe with alcohol is not allowed; The dirty can be wiped with a clean cloth or with clean cloth &alcohol, and the dirt is less than 10% of the total area of the product, and the dirt is less than two points each piece of product, allowed.
17	FPC	 1.The component soldering can not be cold soldering, short, open circuit, burrs, tin ball; 2.The shape of FPC can not been broken, died off; 3.FPC stiffener of the component area can not drain back paste or damaged; 4.FPC version number should be consistent with the design drawing;
18	Tape (foam / double-sided adhesive, etc.) Judgement	Tape attached should be consistent with the design drawing;, not missing , unbreakable, non-attached side.

■ PRECAUTIONS FOR USE OF CTP MODULES

1 Mounting Precaution

1.1 B e z e Mounting

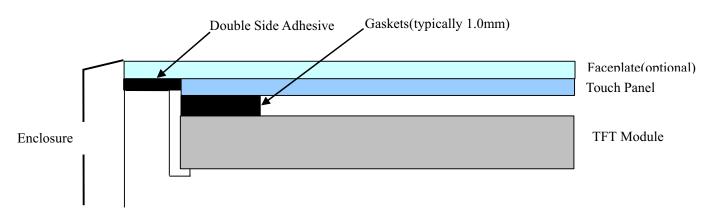
When mounting the CTP underneath a bezel, the CTP assembly should be mounted using a configuration that supports the back surface of the TFT module. The bezel edge must be positioned outside the active area of the CTP. A gap of 0.5mm to 1.0mm is needed between the bezel and the CTP surface. A foam gasket or similar material should be used to compensate for the tolerance of the enclosure, compression for the screw, etc.





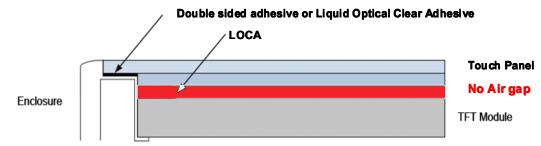
1.2 Flush Mounting

When flush mounting the faceplate with the top of the enclosure, the enclosure must have a ledge for attaching the overhang of the faceplate as well as a ledge for supporting the back of the TFT module.



1.3 Optical Bonding

The airgap between the TFT and CTP can be eliminated by using an optical bonding .Elimination of the air gap improves the electrical performance of the CTP and enhances the clarity of the TFT image.



2 Handling Precautions

- 2.1 The product is made of glass. Do not subject it to a mechanical shock by dropping it from a high place, etc.
- 2.2 Do not apply excessive force to the product since this may damage to the performance;
- 2.3 If the display surface is contaminated, breathe on the surface and gently wipe it with a soft dry cloth. If still not completely clear, moisten cloth with one of the following solvents:
 - Isopropyl alcohol
 - Ethyl alcohol

Solvents other than those mentioned above may damage the product. Especially, do not use the following:

- Water
- Ketone
- Aromatic solvents

- 2.4 Do not attempt to disassemble the CTP Module.
- 2.5 If the logic circuit power is off, do not apply the input signals.
- 2.6 To prevent destruction of the elements by static electricity, be careful to maintain an optimum work environment.
 - a. Be sure to ground the body when handling theCTP Modules.
 - b. Tools required for assembly, such as soldering irons, must be properly ground.
 - c. To reduce the amount of static electricity generated, do not conduct assembly and other work under dry conditions.
 - d. The CTP Module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

3 Storage precautions

- 3.1 When storing the CTP modules, avoid exposure to direct sunlight or to the light of fluorescent lamps.
- 3.2 The CTP modules should be stored under the storage temperature range. If the CTP modules will be stored for a long time, the recommend condition is: Temperature : 0°C ~ 40°C
 Relatively humidity: ≤80%
- 3.3 The LCD modules should be stored in the room without acid, alkali and harmful gas.

4 notes

The CTP modules should be no falling and violent shocking during transportation, and also should avoid excessive press, water, damp and sunshine.



OUTLINE DRAWING

